

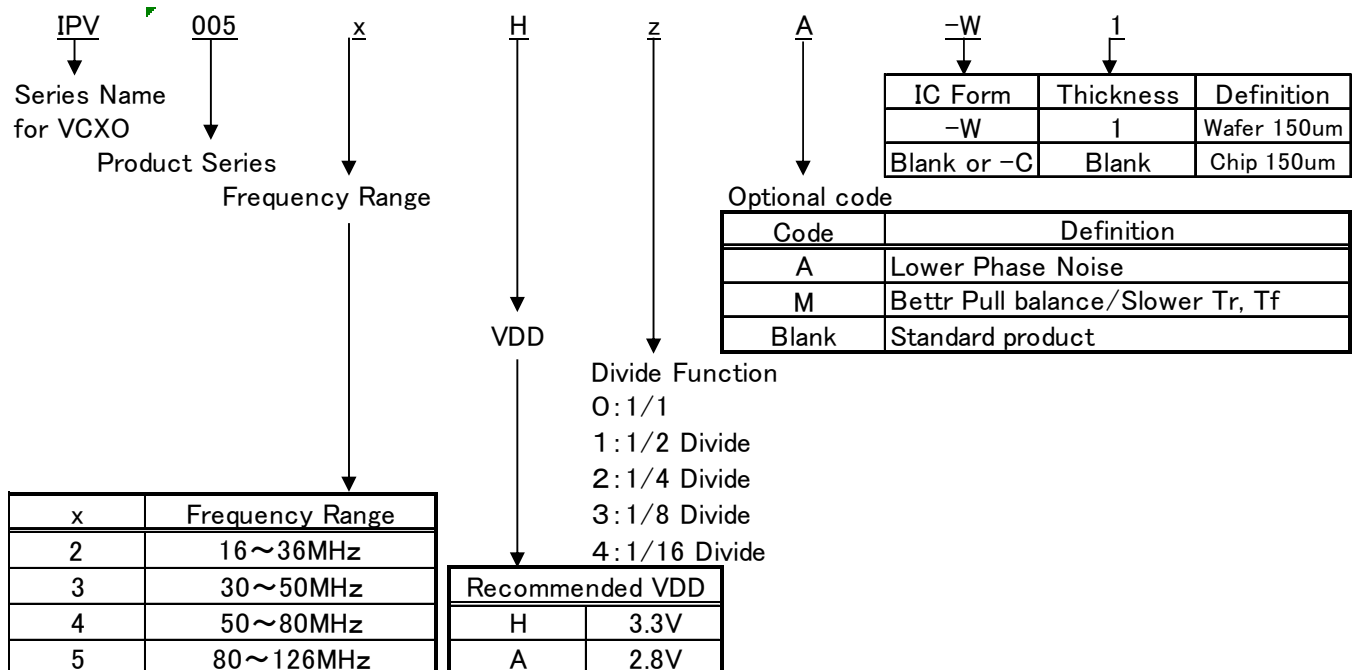
■ Description

IPV005xH and IPV005xA Series IC is a single chip VCXO IC with built-in Variable Capacitor. This product has the features of the wide pulling range, the low power consumption and a stable output against voltage fluctuation by the built-in the original voltage variable capacitor and high precision constant voltage circuit. Also the small chip size of this product enables a smaller VCXO having output frequency from 1MHz to 126MHz.

■ Features

- Operation temperature : 125°C (Except IPV0055)
- Power supply voltage : 2.52~3.63V
- Vc Input impedance : 5MΩ
- Standby function : Output disable
- Crystal frequency : 16~126MHz
- Low power consumption : 3mA (IPV0052H)
- Output : CMOS
- Divide function : 1/2, 1/4, 1/8 and 1/16
- Small chip size : 0.75mm × 1.00mm
- Frequency stability to Vdd : Within ±1ppm
- Wide pulling range : ±100ppm minimum / Vc=1.65±1.35V
- Duty cycle : Within 50±5%

1. Part number rule



2. Series

Part Number	Output Frequency (MHz)		Divide	Remarks
	Min.	Max.		
IPV005 2 H 0	16.00	36.00	1/1	
IPV005 2 H 1	8.00	18.00	1/2	
IPV005 2 H 2	4.00	9.00	1/4	
IPV005 2 H 3	2.00	4.50	1/8	
IPV005 2 H 4	1.00	2.25	1/16	
IPV005 3 H 0	30.00	50.00	1/1	
IPV005 3 H 1	15.00	25.00	1/2	
IPV005 3 H 2	7.50	12.50	1/4	
IPV005 4 H 0	50.00	80.00	1/1	Wider Frequency range than 54H0M
IPV005 4 H 1	25.00	40.00	1/2	Better Pull balance than 54H0
IPV005 4 H 0 M	45.00	60.00	1/1	
IPV005 5 H 0	80.00	126.00	1/1	Tr, Tf is Slower than 55H0 Lower Phase Noise
IPV005 5 H 0 M	80.00	126.00	1/1	
IPV005 5 H 0 A	80.00	126.00	1/1	
IPV005 2 A 0	16.00	36.00	1/1	
IPV005 2 A 1	8.00	18.00	1/2	
IPV005 2 A 2	4.00	9.00	1/4	
IPV005 3 A 0	30.00	54.00	1/1	
IPV005 3 A 1	15.00	27.00	1/2	

3. Absolute Maximum Ratings $V_{SS}=0V$, $T_a=+25^{\circ}C \pm 2^{\circ}C$

Parameter	Symbol	Condition	Ratings		
			Min	Max	Unit
Supply Voltage	V_{DD}		$V_{SS}-0.5$	7	V
Input Voltage	V_{IN}	All Input Pin	$V_{SS}-0.5$	$V_{DD}+0.5$	V
Output Voltage	V_{OUT}		$V_{SS}-0.5$	$V_{DD}+0.5$	V
Output Current	I_{OUT}			30	mA
Junction Temperature	T_j		-55	150	$^{\circ}C$
Storage Temperature	T_{stg}		-55	125	$^{\circ}C$

4. Recommended Operating Condition $V_{SS}=0V, T_a = -40^{\circ}C \sim +125^{\circ}C$ (85°C with IPV0055)

Parameter	Symbol	Condition	Min	Typ	Max	Unit	Note
Supply Voltage	V_{DD}		2.52	3.3	3.63	V	V_{DD}
“H” Input Voltage	V_{IH}		$V_{DD} \times 0.7$			V	OE
“L” Input Voltage	V_{IL}				$V_{DD} \times 0.3$	V	OE
Input Voltage	V_{IN}		V_{SS}		V_{DD}	V	OE
Control Voltage	V_C	$2.52V \leq V_{DD} \leq 3.63V$	0		$V_{DD} + 1.0$	V	VC
Output Load Capacitance	IPV0052H	CL	CMOS	15	30	pF	OUT
	IPV005xA						
	IPV0053H				15		
	IPV0054H IPV0055H						
Ambient Temperature 1	T_{opT}	Except IPV0055	-40		125	°C	
Ambient Temperature 2	T_{opT}	IPV0055	-40		85	°C	

This IC has enough immunity against ESD and Latch-up, but handle with care.

5. Electrical Specification

5-1 IPV0052Hz, 53Hz, 54Hz Unless otherwise stated, $V_{DD}=2.52V \sim 3.63V, V_{SS}=0V,$
 $T_a = -40 \sim 125^{\circ}C$

Parameter	Symbol	Condition	Specification				Unit
			Min	Typ	Max	125°C	
“H” input current	I_{IH}	$V_{IN}=V_{DD}$			1	←	μA
“L” input current	I_{IL}	$V_{IN}=V_{SS}$		1.3	10	←	μA
“H” output voltage	V_{OH}	$I_{OH}=-5mA$	$V_{DD}-0.4$			$I_{OH}=-3mA$	V
“L” output voltage	V_{OL}	$I_{OL}=5mA$			0.4	$I_{OL}=3mA$	V
Current consumption	I_{DD}	CL=15pF, $V_{DD}=3.63V,$ OE $\geq V_{DD}-0.3V,$ F ₀ =27MHz		3	5	←	mA
Current consumption at output disable	I_{DDD}	CL=15pF, $V_{DD}=3.63V,$ OE $\leq 0.3V, F_0=27MHz$		1	2	←	mA
Output off leak at output disable	I_o	OE $\leq 0.3V$			10	←	μA
Output Duty Ratio	Duty	CL=15pF, F ₀ =27MHz, V _c =1/2V _{DD}	45		55	43Min 57Max	%
Pull Range	F _{cntr}	V _c =+1.65±1.35V 27MHz, Crystal *1	±110			←	ppm
Rise time	IPV0052	CL=15pF, 10~90% VDD		3.0	4.5	6.0Max	ns
	IPV0053			2.5	3.5	4.7Max	
	IPV0054			2.0	3.0	4.0Max	
Fall time	IPV0052	CL=15pF, 10~90% VDD		3.0	4.5	6.0Max	ns
	IPV0053			2.5	3.5	4.7Max	
	IPV0054			2.0	3.0	4.0Max	
Output Enable Time	T _{pe}				100	←	ns
Output Disable Time	T _{pd}				100	←	ns
Modulation Band Width	F _c	V _c =1.35sinωt+1.65V	15	20		←	KHz

Crystal *1 ; Equivalent Parameter of Crystal is $\gamma = C_0/C_1 < 300$

5-2 IPV0054H0M

 Unless otherwise stated, $V_{DD}=2.52V\sim 3.63V$, $V_{SS}=0V$,
 $T_a = -40\sim 85^{\circ}C$

Parameter	Symbol	Condition	Specification			Unit
			Min	Typ	Max	
“H” input current	I_{IH}	$V_{IN}=V_{DD}$			1	μA
“L” input current	I_{IL}	$V_{IN}=V_{SS}$			10	μA
“H” output voltage	V_{OH}	$I_{OH}=-5mA$	$V_{DD}-0.4$			V
“L” output voltage	V_{OL}	$I_{OL}=5mA$			0.4	V
Current consumption	I_{DD}	$CL=15pF$, $V_{DD}=3.63V$, $OE\geq V_{DD}-0.3V$, $F_0=54MHz$		6	10	mA
Current consumption at output disable	I_{DDD}	$CL=15pF$, $V_{DD}=3.63V$, $OE\leq 0.3V$, $F_0=54MHz$		2	3	mA
Output off leak at output disable	I_o	$OE\leq 0.3V$			10	μA
Output Duty Ratio	Duty	$CL=15pF$, $F_0=54MHz$, $V_c=1/2V_{DD}$	45		55	%
Pull Range	F_{centr}	$V_c=+1.65\pm 1.35V$ Crystal *1	± 110			ppm
Rise time	T_r	$CL=15pF$, $10\sim 90\% V_{DD}$		2.0	3.0	ns
Fall time	T_f	$CL=15pF$, $10\sim 90\% V_{DD}$		2.0	3.0	ns
Output Enable Time	T_{pe}				100	ns
Output Disable Time	T_{pd}				100	ns
Modulation Band Width	F_c	$V_c=1.35\sin\omega t+1.65V$	15	20		KHz

 Crystal *1 ; Equivalent Parameter of Crystal is $\gamma = C_0/C_1 < 300$

5-3 IPV0055H0

 Unless otherwise stated, $V_{DD}=2.52V\sim 3.63V$, $V_{SS}=0V$, $T_a = -40\sim 85^{\circ}C$

Parameter	Symbol	Condition	Specification			Unit	
			Min	Typ	Max		
“H” input current	I_{IH}	$V_{IN}=V_{DD}$			1	μA	
“L” input current	I_{IL}	$V_{IN}=V_{SS}$			100	μA	
“H” output voltage	V_{OH}	$I_{OH}=-5mA$	$V_{DD}-0.4$			V	
“L” output voltage	V_{OL}	$I_{OL}=5mA$			0.4	V	
Current consumption	I_{DD}	$CL=15pF$, $V_{DD}=3.63V$, $OE\geq V_{DD}-0.3V$, $F_0=126MHz$		16	20	mA	
Current consumption at output disable	I_{DDD}	$CL=15pF$, $V_{DD}=3.63V$, $OE\leq 0.3V$, $F_0=126MHz$		8.6	10	mA	
Output off leak at output disable	I_o	$OE\leq 0.3V$			10	μA	
Output Duty Ratio	Duty	$CL=15pF$, $V_c=1/2V_{DD}$	80MHz	45		55	%
			120MHz	45		55	%
			126MHz	40		60	%
Pull Range	F_{cntr}	$V_c=1.65\pm 1.65V$ Crystal *1	80MHz	± 110			ppm
			100MHz	± 100			ppm
			126MHz	± 90			ppm
Rise time	T_r	$CL=15pF$, 10~90% VDD		1.5	1.9	ns	
Fall time	T_f	$CL=15pF$, 10~90% VDD		1.4	1.9	ns	
Output Enable Time	T_{pe}				100	ns	
Output Disable Time	T_{pd}				100	ns	
Modulation Band Width	F_c	$V_c=1.35\sin\omega t+1.65V$	15			KHz	

 Crystal *1 ; Equivalent Parameter of Crystal is $\gamma=C_0/C_1<300$

5-4 IPV0055H0M

 Unless otherwise stated, $V_{DD}=2.52V\sim 3.63V$, $V_{SS}=0V$, $T_a = -40\sim 85^{\circ}C$

Parameter	Symbol	Condition	Specification			Unit
			Min	Typ	Max	
“H” input current	I_{IH}	$V_{IN}=V_{DD}$			1	μA
“L” input current	I_{IL}	$V_{IN}=V_{SS}$			100	μA
“H” output voltage	V_{OH}	$I_{OH}=-5mA$	$V_{DD}-0.4$			V
“L” output voltage	V_{OL}	$I_{OL}=5mA$			0.4	V
Current consumption	I_{DD}	$CL=15pF$, $V_{DD}=3.63V$, $OE\geq V_{DD}-0.3V$, $F_0=126MHz$		16	20	mA
Current consumption at output disable	I_{DDD}	$CL=15pF$, $V_{DD}=3.63V$, $OE\leq 0.3V$, $F_0=126MHz$		8.6	10	mA
Output off leak at output disable	I_o	$OE\leq 0.3V$			10	μA
Output Duty Ratio	Duty	$CL=15pF$, $V_c=1/2V_{DD}$	80MHz	45	55	%
			120MHz	45	55	%
			126MHz	40	60	%
Pull Range	F_{cntr}	$V_c=1.65\pm 1.35V$ Crystal *1	80MHz	± 110		ppm
			100MHz	± 100		ppm
			126MHz	± 90		ppm
Rise time	T_r	$CL=15pF$, 10~90% VDD		2.5	4.0	ns
Fall time	T_f	$CL=15pF$, 10~90% VDD		2.0	3.5	ns
Output Enable Time	T_{pe}				100	ns
Output Disable Time	T_{pd}				100	ns
Modulation Band Width	F_c	$V_c=1.35\sin\omega t+1.65V$	15			KHz

 Crystal *1 ; Equivalent Parameter of Crystal is $\gamma = C_0/C_1 < 300$

5-5 IPV0055H0A Unless otherwise stated, $V_{DD}=2.52V\sim 3.63V$, $V_{SS}=0V$, $T_a = -40\sim 85^{\circ}C$

Parameter	Symbol	Condition	Specification			Unit	
			Min	Typ	Max		
“H” input current	I_{IH}	$V_{IN}=V_{DD}$			1	μA	
“L” input current	I_{IL}	$V_{IN}=V_{SS}$			100	μA	
“H” output voltage	V_{OH}	$I_{OH}=-5mA$	$V_{DD}-0.4$			V	
“L” output voltage	V_{OL}	$I_{OL}=5mA$			0.4	V	
Current consumption	I_{DD}	$CL=15pF$, $V_{DD}=3.63V$, $OE\geq V_{DD}-0.3V$, $F_0=126MHz$		16	20	mA	
Current consumption at output disable	I_{DDD}	$CL=15pF$, $V_{DD}=3.63V$, $OE\leq 0.3V$, $F_0=126MHz$		8.6	10	mA	
Output off leak at output disable	I_O	$OE\leq 0.3V$			10	μA	
Output Duty Ratio	Duty	$CL=15pF$, $V_c=1/2V_{DD}$	80MHz	45		55	%
			120MHz	45		55	%
			126MHz	40		60	%
Pull Range	F_{centr}	$V_c=1.65\pm 1.65V$ Crystal *1	80MHz	± 110			ppm
			100MHz	± 100			ppm
			126MHz	± 90			ppm
Rise time	T_r	$CL=15pF$, 10~90% VDD		1.5	1.9	ns	
Fall time	T_f	$CL=15pF$, 10~90% VDD		1.4	1.9	ns	
Output Enable Time	T_{pe}				100	ns	
Output Disable Time	T_{pd}				100	ns	
Modulation Band Width	F_c	$V_c=1.35\sin\omega t+1.65V$	15			KHz	

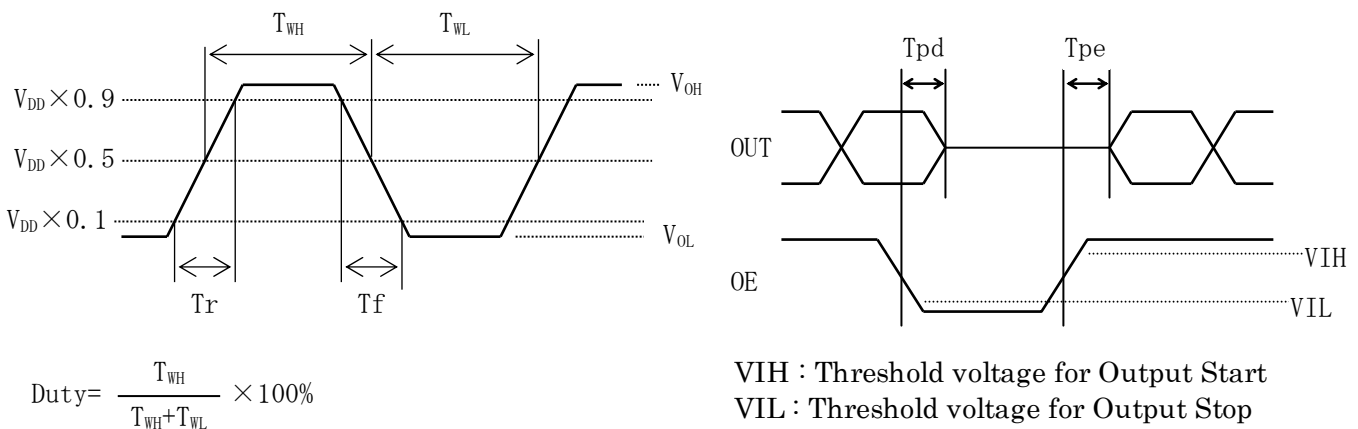
 Crystal *1 ; Equivalent Parameter of Crystal is $\gamma=C_0/C_1<300$
Phase Noise comparison
F=122MHz, $V_c=1.65V$, Room Temperature

Offset	IPV0055H0	IPV0055H0A
10Hz	-69 dBc	-70 dBc
100Hz	-101 dBc	-103 dBc
1KHz	-126 dBc	-127 dBc
10KHz	-140 dBc	-145 dBc
100KHz	-154 dBc	-156 dBc
1MHz	-160 dBc	-161 dBc
10MHz	-162 dBc	-162 dBc

Phase Jitter	IPV0055H0	IPV0055H0A
12KHz~20MHz	71 fs	66 fs

5-6 IPV005xAz Unless otherwise stated, $V_{DD}=2.52V\sim 3.63V$, $V_{SS}=0V$, $T_a = -40\sim 125^{\circ}C$

Parameter	Symbol	Condition	Specification				Unit
			Min	Typ	Max	125°C	
“H” input current	I_{IH}	$V_{IN}=V_{DD}$			1	←	μA
“L” input current	I_{IL}	$V_{IN}=V_{SS}$		1.3	10	←	μA
“H” output voltage	V_{OH}	$I_{OH}=-5mA$	$V_{DD}-0.4$			$I_{OH}=-3mA$	V
“L” output voltage	V_{OL}	$I_{OL}=5mA$			0.4	$I_{OL}=3mA$	V
Current consumption	I_{DD}	$CL=15pF$, $V_{DD}=3.0V$, $OE\geq V_{DD}-0.3V$, $F_0=27MHz$		2.0	3.3	4.5	mA
Current consumption at output disable	I_{DDD}	$CL=15pF$, $V_{DD}=3.0V$, $OE\leq 0.3V$, $F_0=27MHz$		0.5	1.0	1.8	mA
Output off leak at output disable	I_o	$OE\leq 0.3V$			10	←	μA
Output Duty Ratio	IPV0052Az	Duty	$CL=15pF$, $F_0=27MHz$, $V_c=1/2V_{DD}$	45	55	43Min 58Max	%
	IPV0053Az			43	58	←	%
Pull Range	F_{entr}	$V_{DD}=2.8V$, $V_c=1.40\pm 1.40V$ 27MHz, Crystal *1	±100			←	ppm
Rise time	T_r	$CL=15pF$, 10~90% VDD		3.0	4.5	6.0Max	ns
Fall time	T_f	$CL=15pF$, 10~90% VDD		3.0	4.5	6.0Max	ns
Output Enable Time	T_{pe}				100	←	ns
Output Disable Time	T_{pd}				100	←	ns
Modulation Band Width	F_c	$V_c=1.40\sin\omega t+1.40V$	15	20		←	KHz

 Crystal *1 ; Equivalent Parameter of Crystal is $\gamma = C_0/C_1 < 300$

 Fig. 5-1 Output Wave Form (Duty, T_r , T_f , T_{pd} , T_{pe})

6. Circuit Parameters of Oscillator (Reference Data for Circuit Design)
 $V_{DD}=3.3V$ 、 $V_{SS}=0V$ 、 $T_a = 25^{\circ}C$ 、 $V_c=V_{SS} \sim V_{DD}$

Parameter		Symbol	Condition	Min	Typ	Max	Unit
Feedback Resistor		Rf	Refer to Fig. 6-1	80	100	120	K Ω
Driving Resistor	IPV0052H, A	Rd		0.95	1.20	1.45	K Ω
	IPV0053H, A			0.50	0.60	0.70	
	IPV0054H			0.08	0.10	0.12	
	IPV0054H0M			0.24	0.30	0.36	
	IPV0055H0, H0A			0.40	0.50	0.60	
	IPV0055H0M			0.08	0.10	0.12	
Bias Resistor	All series except below.	Rv1		200	240	280	K Ω
		Rv2		96	120	145	K Ω
	IPV005xA	Rv1		150	180	210	K Ω
		Rv2		75	90	105	K Ω
Input Resistor		Rvc1			20		K Ω
VC Input impedance		Rvc	VC terminal to GND	5			M Ω
Equivalent series (Loading) Capacitance	IPV0052H, A 27MHz	CLxtal	Vc=0V		10.7		pF
			Vc=1.65V, 1.4V		6.0		
			Vc=3.3V, 3.0V		3.7		
	IPV0053H, A 47MHz		Vc=0V		10.7		
			Vc=1.65V, 1.4V		6.0		
			Vc=3.3V, 3.0V		3.7		
	IPV0054H 60MHz		Vc=0V		7.5		
			Vc=1.65V		3.0		
			Vc=3.3V		2.3		
	IPV0055H0, H0A 120MHz		Vc=0V		4.5		
			Vc=1.65V		2.2		
			Vc=3.3V		1.5		
Drive Level	IPV0054H0M	DL	Vc=0V		240		μ W
			Vc=1.65V		200		
			Vc=3.3V		160		
	IPV0055H		Vc=0V		410		
			Vc=1.65V		390		
			Vc=3.3V		320		
Frequency deviation by IC		$\Delta f_c/f_c$	Crystal fixed			25	ppm
DC cut Capacitor	All series except below.	Cpg		13	16	19	pF
		Cpd		40	50	60	
	IPV0055H0, H0A	Cpg		10	12	14	
		Cpd		38	48	58	
	IPV0055H0M	Cpg		10	12	14	
		Cpd		40	50	60	

*The above values are the design values and are not guaranteed by test.

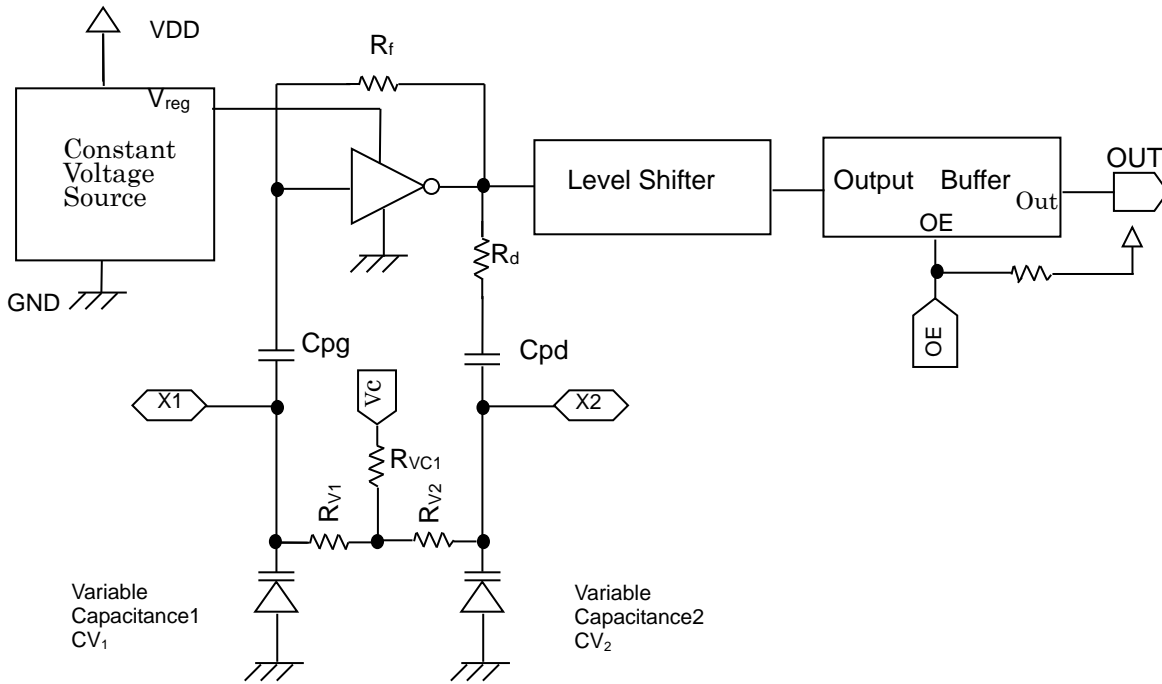
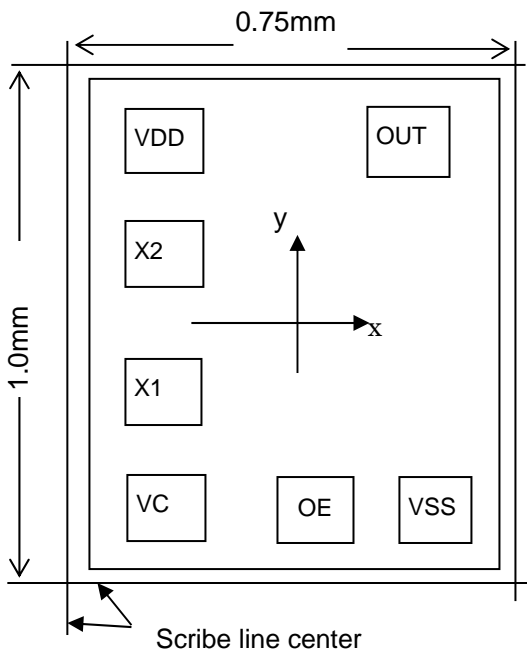


Fig. 6-1 Block Diagram

7. Pad Layout



- Die Size: 0.75mm × 1.0mm
- Pad Size: 80um □
- Thickness: 150 ± 20um
- IC Backside: Gnd or Open

Pad Name	Function	Location (μm)	
		x	y
VC	Frequency Control Input	-244	-359
OE	Output Enable, "L": High-Impedance *1)	44	-359
VSS	(-)Ground	244	-359
OUT(Q)	Frequency Output	179	359
VDD	(+)Power Supply	-244	359
X2	Crystal Drive	-244	132
X1	Crystal Feedback	-244	-132
Chip Center		0	0

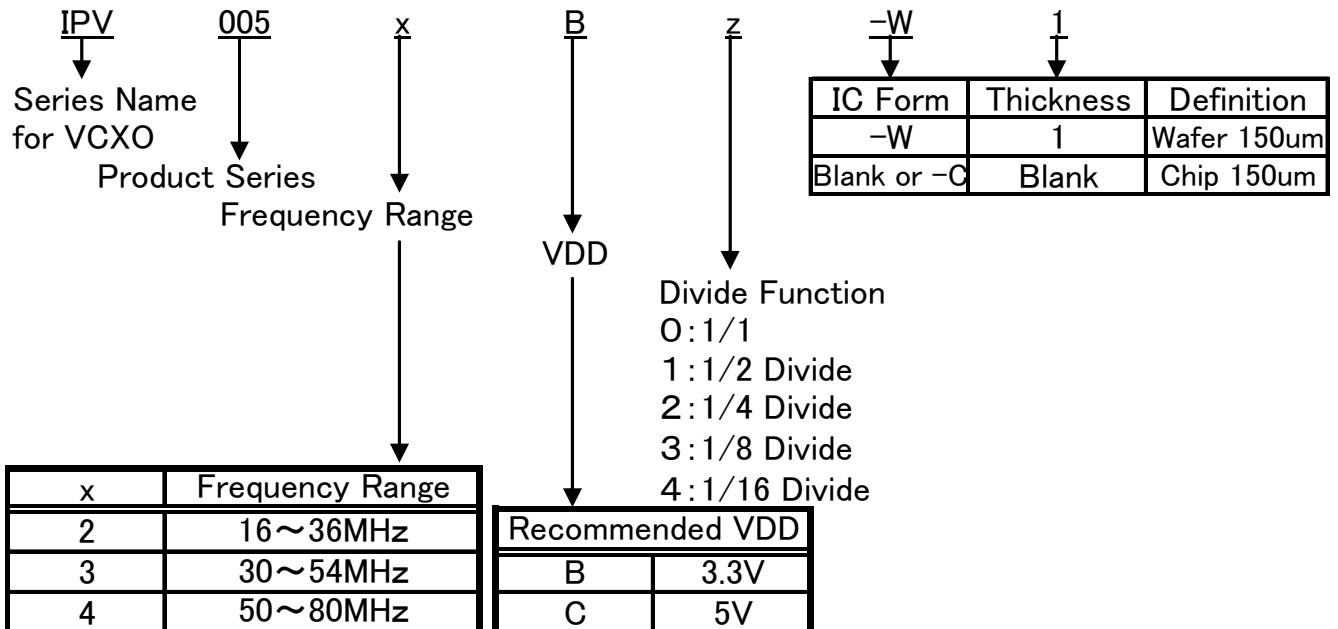
*1) : 2.5MΩ Typ.

■ Description

IPV005xB and IPV005xC Series IC is a single chip VCXO IC with built-in Variable Capacitor. This product has the features of the wide pulling range, the low power consumption and a stable output against voltage fluctuation by the built-in the original voltage variable capacitor and high precision constant voltage circuit. Also the small chip size of this product enables a smaller VCXO having output frequency from 1MHz to 80MHz.

■ Features

- Operation temperature : 125°C
- Power supply voltage : 2.52~3.63V / IPV005xB and 4.5~5.5V / IPV005xC
- Vc Input impedance : 100KΩ
- Standby function : Output disable
- Crystal frequency : 16~80MHz
- Low power consumption : 3mA (IPV0052B)
- Output : CMOS
- Divide function : 1/2, 1/4, 1/8 and 1/16
- Small chip size : 0.75mm × 1.00mm
- Frequency stability to Vdd : Within ±1ppm
- Wide pulling range : ±100ppm minimum / Vc=1.65±1.35V
- Duty cycle : Within 50±5%

1. Part number rule


2. Series

Part Number	Output Frequency (MHz)		Divide	Remarks
	Min.	Max.		
IPV005 2 B 0	16.00	36.00	1/1	
IPV005 2 B 1	8.00	18.00	1/2	
IPV005 2 B 2	4.00	9.00	1/4	
IPV005 2 B 3	2.00	4.50	1/8	
IPV005 2 B 4	1.00	2.25	1/16	
IPV005 3 B 0	30.00	54.00	1/1	
IPV005 3 B 1	15.00	27.00	1/2	
IPV005 3 B 2	7.50	13.50	1/4	
IPV005 4 B 0	50.00	80.00	1/1	
IPV005 2 C 0	16.00	36.00	1/1	
IPV005 2 C 1	8.00	18.00	1/2	
IPV005 2 C 2	4.00	9.00	1/4	
IPV005 2 C 3	2.00	4.50	1/8	
IPV005 2 C 4	1.00	2.25	1/16	
IPV005 3 C 0	30.00	54.00	1/1	
IPV005 4 C 0	50.00	80.00	1/1	

3. Absolute Maximum Ratings $V_{SS}=0V$, $T_a=+25^{\circ}C \pm 2^{\circ}C$

Parameter	Symbol	Condition	Ratings		
			Min	Max	Unit
Supply Voltage	V_{DD}		$V_{SS}-0.5$	7	V
Input Voltage	V_{IN}	All Input Pin	$V_{SS}-0.5$	$V_{DD}+0.5$	V
Output Voltage	V_{OUT}		$V_{SS}-0.5$	$V_{DD}+0.5$	V
Output Current	I_{OUT}			30	mA
Junction Temperature	T_j		-55	150	$^{\circ}C$
Storage Temperature	T_{stg}		-55	125	$^{\circ}C$

4. Recommended Operating Condition $V_{SS}=0V, T_a = -40^{\circ}C \sim +125^{\circ}C$

Parameter		Symbol	Condition	Min	Typ	Max	Unit	Note
Supply Voltage	IPV005xB	V_{DD}		2.52	3.3	3.63	V	V_{DD}
	IPV005xC	V_{DD}		4.5	5.0	5.5	V	V_{DD}
“H” Input Voltage		V_{IH}		$V_{DD} \times 0.7$			V	OE
“L” Input Voltage		V_{IL}				$V_{DD} \times 0.3$	V	OE
Input Voltage		V_{IN}		V_{SS}		V_{DD}	V	OE
Control Voltage	IPV005xB	V_C	$2.52V \leq V_{DD} \leq 3.63V$	0		$V_{DD} + 1.0$	V	VC
	IPV005xC	V_C	$4.5V \leq V_{DD} \leq 5.5V$	0		$V_{DD} + 0.5$	V	VC
Output Load Capacitance	IPV0052C	CL	CMOS		15	30	pF	OUT
	IPV005xB							
	IPV0053C					15		
	IPV0054C							
Ambient Temperature		T_{opT}		-40		125	$^{\circ}C$	

This IC has enough immunity against ESD and Latch-up, but handle with care.

5. Electrical Specification
5-1 IPV005xB

 Unless otherwise stated, $V_{DD}=2.52V\sim 3.63V$, $V_{SS}=0V$, $T_a = -40\sim 125^{\circ}C$

Parameter	Symbol	Condition	Specification				Unit	
			Min	Typ	Max	125°C		
“H” input current	I_{IH}	$V_{IN}=V_{DD}$			1	←	μA	
“L” input current	I_{IL}	$V_{IN}=V_{SS}$		1.3	10	←	μA	
“H” output voltage	V_{OH}	$I_{OH}=-5mA$	$V_{DD}-0.4$			$I_{OH}=-3mA$	V	
“L” output voltage	V_{OL}	$I_{OL}=5mA$			0.4	$I_{OL}=3mA$	V	
Current consumption	I_{DD}	$CL=15pF$, $V_{DD}=3.63V$, $OE\geq V_{DD}-0.3V$, $F_0=27MHz$		3.0	5.0	←	mA	
Current consumption at output disable	I_{DDD}	$CL=15pF$, $V_{DD}=3.63V$, $OE\leq 0.3V$, $F_0=27MHz$		1.0	2.0	←	mA	
Output off leak at output disable	I_o	$OE\leq 0.3V$			10	←	μA	
Output Duty Ratio	IPV0052B	Duty	$CL=15pF$, $F_0=27MHz$, $V_c=1/2V_{DD}$	45		55	43Min 57Max	%
	IPV0053B		$CL=15pF$, $F_0=47MHz$, $V_c=1/2V_{DD}$	43		58	←	%
	IPV0054B		$CL=15pF$, $F_0=77MHz$, $V_c=1/2V_{DD}$	40		60	←	%
Pull Range	F_{ctr}	$V_c=+1.65\pm 1.35V$ 27MHz, Crystal *1	±110			←	ppm	
Rise time	IPV0052B	Tr	$CL=15pF$, 10~90% VDD		3.0	4.5	6.0Max	ns
	IPV0053B				2.5	3.5	4.7Max	
	IPV0054B				2.0	3.0	4.0Max	
Fall time	IPV0052B	Tf	$CL=15pF$, 10~90% VDD		3.0	4.5	6.0Max	ns
	IPV0053B				2.5	3.5	4.7Max	
	IPV0054B				2.0	3.0	4.0Max	
Output Enable Time	T_{pe}				100	←	ns	
Output Disable Time	T_{pd}				100	←	ns	
Modulation Band Width	F_c	$V_c=1.35\sin\omega t+1.65V$	15	20		←	KHz	

 Crystal *1 ; Equivalent Parameter of Crystal is $\gamma=C_0/C_1<300$

5-2 IPV005xC

 Unless otherwise stated, $V_{DD}=4.5V\sim 5.5V$, $V_{SS}=0V$, $T_a = -40\sim 125^{\circ}C$

Parameter	Symbol	Condition	Specification				Unit	
			Min	Typ	Max	125°C		
“H” input current	I_{IH}	$V_{IN}=V_{DD}$			1	←	μA	
“L” input current	I_{IL}	$V_{IN}=V_{SS}$		1.3	10	←	μA	
“H” output voltage	V_{OH}	$I_{OH}=-5mA$	$V_{DD}-0.4$			$I_{OH}=-3mA$	V	
“L” output voltage	V_{OL}	$I_{OL}=5mA$			0.4	$I_{OL}=3mA$	V	
Current consumption	I_{DD}	$CL=15pF$, $V_{DD}=5.5V$, $OE\geq V_{DD}-0.3V$, $F_0=27MHz$		4.0	6.0	7.0Max	mA	
Current consumption at output disable	I_{DDD}	$CL=15pF$, $V_{DD}=5.5V$, $OE\leq 0.3V$, $F_0=27MHz$		1.0	2.0	←	mA	
Output off leak at output disable	I_o	$OE\leq 0.3V$			10	←	μA	
Output Duty Ratio	IPV0052C	Duty	$CL=15pF$, $F_0=27MHz$, $V_c=1/2V_{DD}$	45		55	43Min 57Max	%
	IPV0053C			40		60	←	%
	IPV0054C			40		60	←	%
Pull Range	F_{ctr}	$V_c=+2.5\pm 2.0V$ 27MHz, Crystal *1	± 110			←	ppm	
Rise time	IPV0052C	Tr	$CL=15pF$, 10~90% VDD		3.0	4.5	←	ns
	IPV0053C				2.5	3.5	←	
	IPV0054C				2.0	3.0	←	
Fall time	IPV0052C	Tf	$CL=15pF$, 10~90% VDD		3.0	4.5	←	ns
	IPV0053C				2.5	3.5	←	
	IPV0054C				2.0	3.0	←	
Output Enable Time	T_{pe}				100	←	ns	
Output Disable Time	T_{pd}				100	←	ns	
Modulation Band Width	F_c	$V_c=2.0\sin\omega t+2.5V$	15			←	KHz	

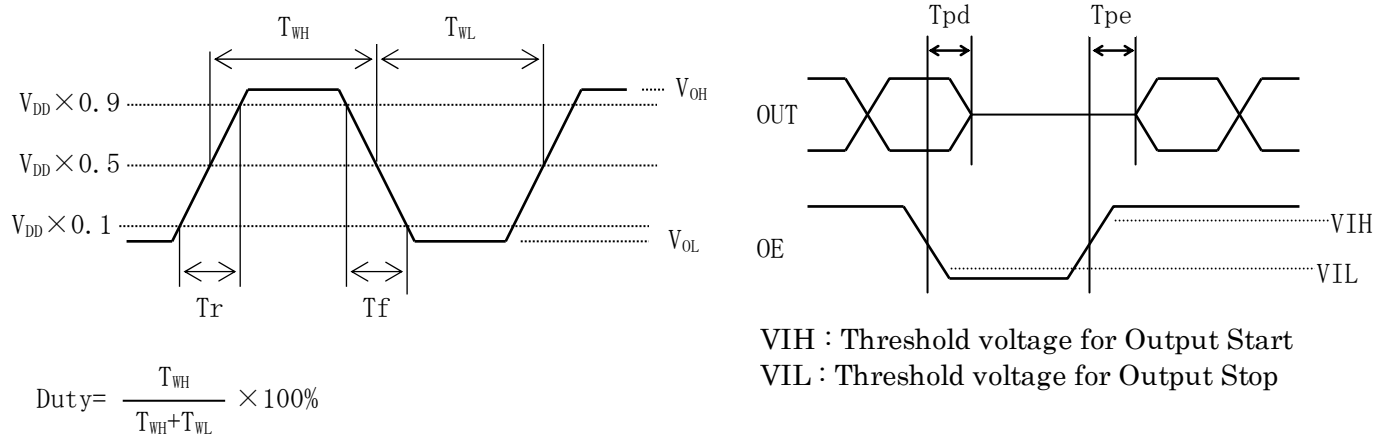
 Crystal *1 ; Equivalent Parameter of Crystal is $\gamma = C_0/C_1 < 300$


Fig. 5-1 Output Wave Form (Duty, Tr, Tf, Tpd, Tpe)

6. Circuit Parameters of Oscillator (Reference Data for Circuit Design)
 $V_{DD}=2.52V\sim 3.63V / \text{IPV005xB}, 5.0V / \text{IPV005xC}, V_{SS}=0V, T_a = 25^\circ\text{C}, V_c=V_{SS} \sim V_{DD}$

Parameter		Symbol	Condition	Min	Typ	Max	Unit
Input Resistor		Rvc1		25	30	35	KΩ
VC Input impedance		Rvc	VC terminal to GND	100			KΩ
Equivalent series (Loading) Capacitance	IPV0052B 27MHz	CLxtal	Vc=0V		10.7		pF
			Vc=1.65V		6.0		
			Vc=3.3V		3.7		
	IPV0053B 47MHz		Vc=0V		10.7		
			Vc=1.65V		6.0		
			Vc=3.3V		3.7		
	IPV0054B 60MHz		Vc=0V		7.5		
			Vc=1.65V		3.0		
			Vc=3.3V		2.3		
	IPV0052C 27MHz		Vc=0V		10.7		
			Vc=2.75V		6.0		
			Vc=5.5V		3.7		
	IPV0053C 47MHz		Vc=0V		10.7		
			Vc=2.75V		6.0		
Vc=5.5V			3.7				
IPV0054C 60MHz	Vc=0V		8.5				
	Vc=2.75V		5.0				
	Vc=5.5V		3.3				
Frequency deviation by IC		$\Delta f_c/f_c$	Crystal fixed			25	ppm

*The above values are the design values and are not guaranteed by test.

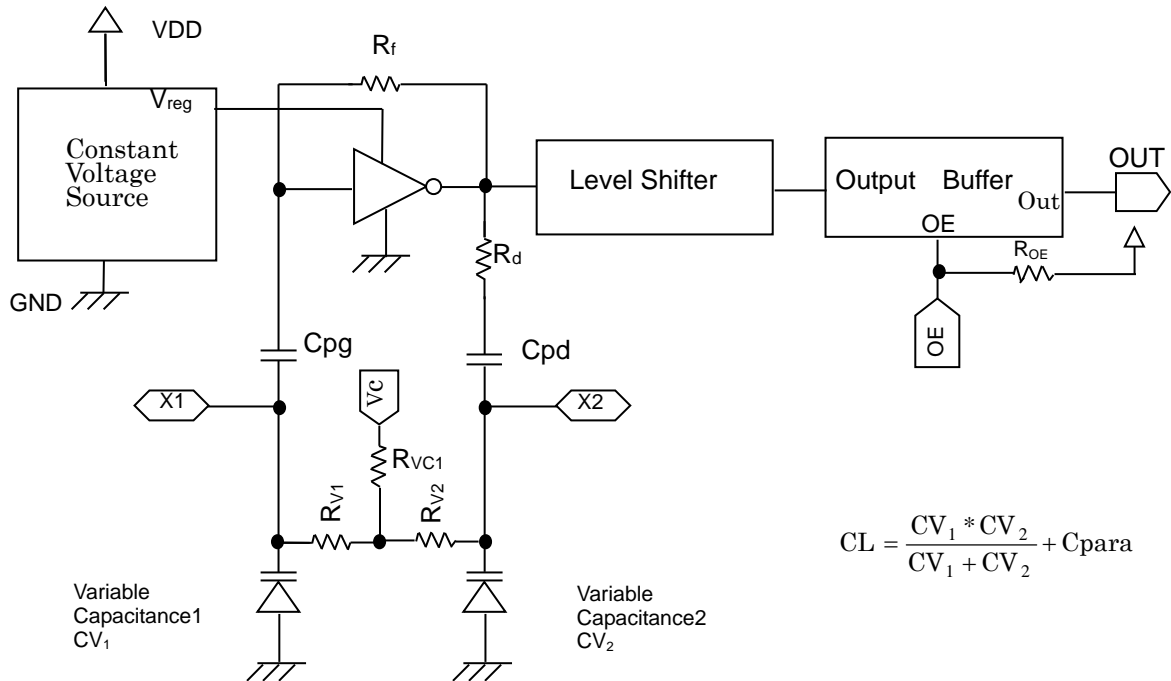
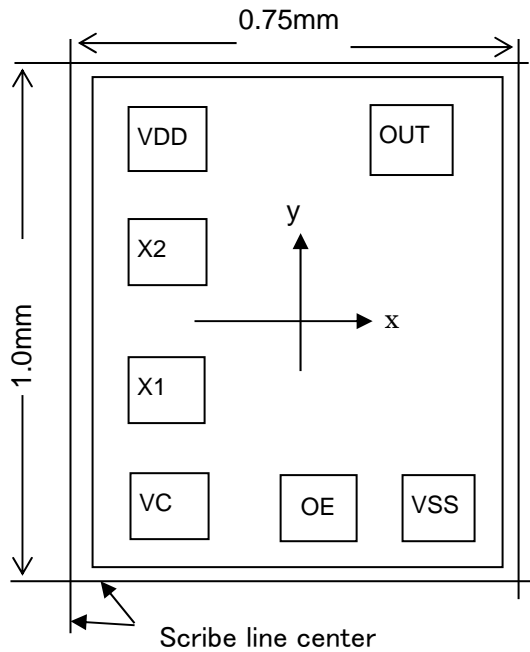


Fig. 6-1 Block Diagram

7. Pad Layout


- Die Size: 0.75mm × 1.0mm
- Pad Size: 80um □
- Thickness: 150±20um
- IC Backside: Gnd or Open

Pad Name	Function	Location (μm)	
		x	y
VC	Frequency Control Input	-244	-359
OE	Output Enable, "L": High-Impedance*1)	44	-359
VSS	(-)Ground	244	-359
OUT(Q)	Frequency Output	179	359
VDD	(+)Power Supply	-244	359
X2	Crystal Drive	-244	132
X1	Crystal Feedback	-244	-132
Chip Center		0	0

*1) : 2.5MΩ Typ.

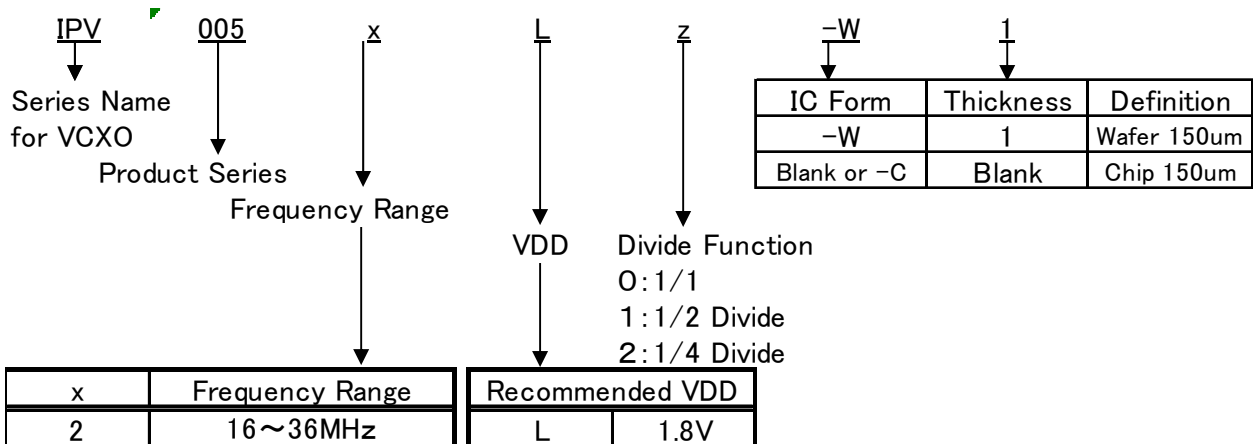
■ Description

IPV005xL Series IC is a single chip VCXO IC with built-in Variable Capacitor. This product has the features of the wide pulling range, the low operation voltage and a stable output against voltage fluctuation by the built-in the original voltage variable capacitor and high precision constant voltage circuit. Also the small chip size of this product enables a smaller VCXO having output frequency from 4MHz to 36MHz.

■ Features

- Operation temperature : 125°C
- Power supply voltage : 1.62~3.0V
- Vc Input impedance : 5MΩ
- Standby function : Oscillation stop
- Crystal frequency : 16~36MHz
- Low power consumption : 1.5mA (IPV0052L)
- Output : CMOS
- Divide function : 1/2 and 1/4
- Small chip size : 0.75mm × 1.00mm
- Frequency stability to Vdd : Within ±1ppm
- Wide pulling range : ±100ppm minimum / Vc=0.9±0.9V
- Duty cycle : Within 50±5%

1. Part number rule



2. Series

Part Number	Output Frequency (MHz)		Divide	Remarks
	Min.	Max.		
IPV005 2 L 0	16.00	36.00	1/1	
IPV005 2 L 1	8.00	18.00	1/2	
IPV005 2 L 2	4.00	9.00	1/4	

3. Absolute Maximum Ratings $V_{SS}=0V$, $T_a=+25^{\circ}C \pm 2^{\circ}C$

Parameter	Symbol	Condition	Ratings		
			Min	Max	Unit
Supply Voltage	V_{DD}		$V_{SS}-0.5$	7	V
Input Voltage	V_{IN}	All Input Pin	$V_{SS}-0.5$	$V_{DD}+0.5$	V
Output Voltage	V_{OUT}		$V_{SS}-0.5$	$V_{DD}+0.5$	V
Output Current	I_{OUT}			30	mA
Junction Temperature	T_j		-55	150	$^{\circ}C$
Storage Temperature	T_{stg}		-55	125	$^{\circ}C$

4. Recommended Operating Condition $V_{SS}=0V$, $T_a = -40^{\circ}C \sim +125^{\circ}C$

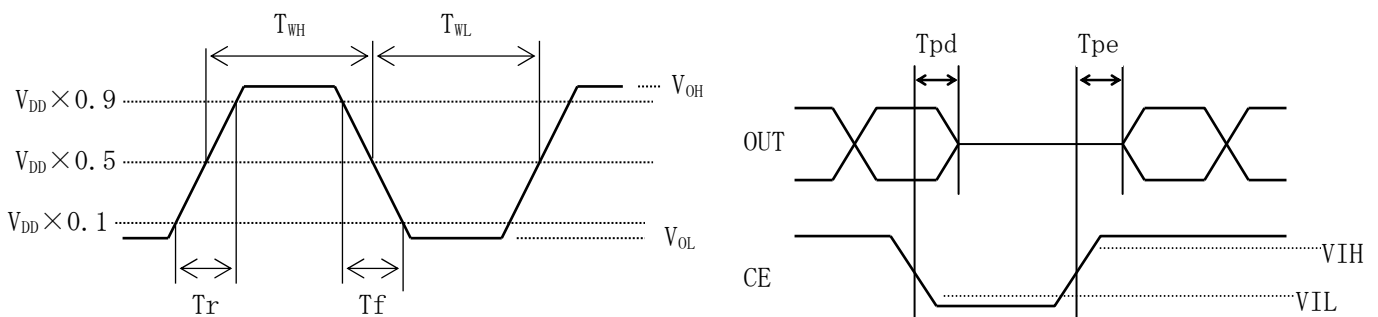
Parameter	Symbol	Condition	Min	Typ	Max	Unit	Note
Supply Voltage	V_{DD}		1.62	1.8	3.0	V	V_{DD}
“H” Input Voltage	V_{IH}		$V_{DD} \times 0.7$			V	CE
“L” Input Voltage	V_{IL}				$V_{DD} \times 0.3$	V	CE
Input Voltage	V_{IN}		V_{SS}		V_{DD}	V	CE
Control Voltage	V_C	$1.62V \leq V_{DD} \leq 3.0V$	0		$V_{DD} + 1.0$	V	VC
Output Load Capacitance	CL	CMOS		15	30	pF	OUT
Ambient Temperature	T_{opT}		-40		125	$^{\circ}C$	

This IC has enough immunity against ESD and Latch-up, but handle with care.

5. Electrical Specification

Unless otherwise stated, VDD=1.62V~3.0V, VSS=0V, T a =-40~125°C

Parameter	Symbol	Condition	Specification				Unit
			Min	Typ	Max	125°C	
“H” input current	I _{IH}	V _{IN} =V _{DD}			1	←	μA
“L” input current	I _{IL}	V _{IN} =V _{SS}		1.3	10	←	μA
“H” output voltage	V _{OH}	I _{OH} =-5mA	V _{DD} -0.4			I _{OH} = -3mA	V
“L” output voltage	V _{OL}	I _{OL} =5mA			0.4	I _{OL} =3mA	V
Current consumption	I _{DD}	CL=15pF, V _{DD} =2.0V, CE≥V _{DD} -0.3V, F0=27MHz		1.5	2.0	2.2Max	mA
Current consumption without output load	I _{DD}	CL=0pF, V _{DD} =1.8V, CE≥V _{DD} -0.3V, F0=27MHz		0.6	1.0	1.2Max	mA
Current consumption at output disable	I _{DD}	CL=15pF, V _{DD} =1.8V, CE≤0.3V, F0=27MHz		0.5	1.0	←	mA
Output off leak at output disable	I _O	CE≤0.3V			10	←	μA
Output Duty Ratio	IPV0052Lz	Duty	CL=15pF, V _{DD} =1.8V, F0=27MHz, V _c =1/2V _{DD}	45	55	43Min 57Max	%
Pull Range	F _{cntr}	V _c =+0.9±0.9V 27MHz, Crystal *1	±100			←	ppm
Rise time	Tr	CL=15pF, 10~90% V _{DD}		5.0	6.5	9.0Max	ns
Fall time	Tf	CL=15pF, 10~90% V _{DD}		5.0	6.5	9.0Max	ns
Output Enable Time	T _{pe}				2	←	ns
Output Disable Time	T _{pd}				100	←	ns
Modulation Band Width	F _c	V _c =0.9sinωt+0.9V	15	20		←	KHz

 Crystal *1 ; Equivalent Parameter of Crystal is $\gamma = C_0/C_1 < 300$


$$\text{Duty} = \frac{T_{WH}}{T_{WH} + T_{WL}} \times 100\%$$

 VIH : Threshold voltage for Oscillation Start
 VIL : Threshold voltage for Oscillation Stop

Fig. 5-1 Output Wave Form (Duty, Tr, Tf, Tpd, Tpe)

6. Circuit Parameters of Oscillator (Reference Data for Circuit Design)
 $V_{DD}=1.62\sim 3.0V, V_{SS}=0V, T_a = 25^{\circ}C, V_c=V_{SS} \sim V_{DD}$

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Input Resistor	R_{VC1}		16	20	25	$K\Omega$
VC Input impedance	R_{vc}	VC terminal to GND	5			$M\Omega$
Equivalent series (Loading) Capacitance	IPV0052L 27MHz	CL_{xtal}		10.7		pF
				6.0		
				3.7		
Frequency deviation by IC	$\Delta f_c/f_c$	Crystal fixed			25	ppm

*The above values are the design values and are not guaranteed by test.

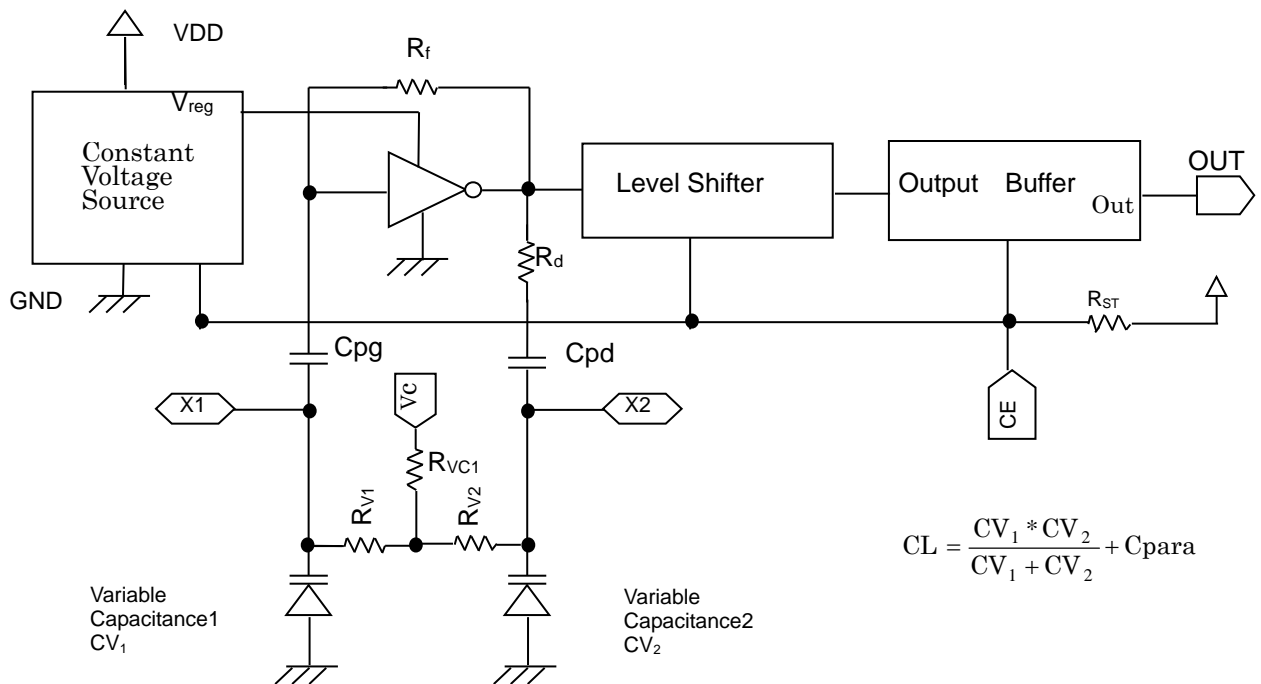
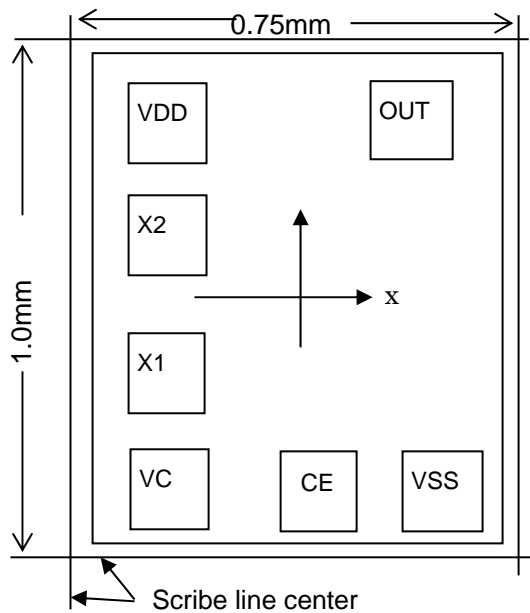


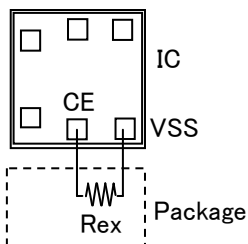
Fig. 6-1 Block Diagram

7. Pad Layout


- Die Size : 0.75mm × 1.0mm
- Pad Size : 80um □
- Thickness : 150±20um
- IC Backside : Gnd or Open

Pad Name	Function	Location (μm)	
		x	y
VC	Frequency Control Input	-244	-359
CE	Oscillation stop, "L": High-Impedance *1)	44	-359
VSS	(-)Ground	244	-359
OUT(Q)	Frequency Output	179	359
VDD	(+)Power Supply	-244	359
X2	Crystal Drive	-244	132
X1	Crystal Feedback	-244	-132
Chip Center		0	0

*1) : 2.5MΩ Typ.


IMPORTANT Notice for CE function

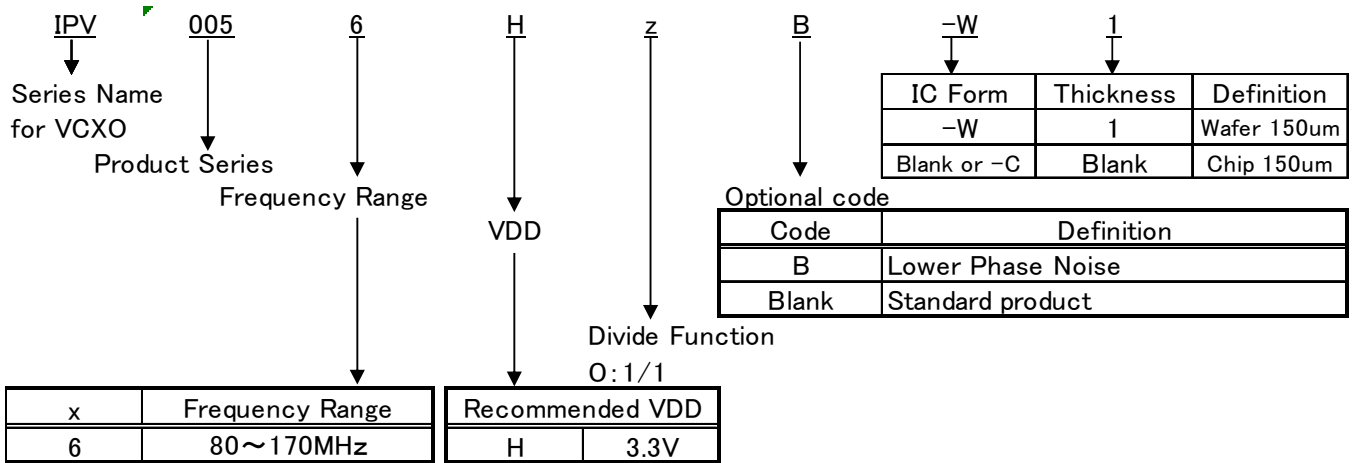
- * Rex should be over 10MΩ in case of CE = Open usage.
 - * Oscillation will not be activated when CE = Open after CE = Low if Rex is below 10MΩ.
 - * There is no such issue in case of CE = VDD usage.
- Rex : External resistance value between CE and VSS of package.

■ Description

IPV0056H Series IC is a single chip VCXO IC that covers high frequency over 80MHz to 170MHz. This product has the features of the wide pulling range and a stable output against voltage fluctuation by the built-in the original voltage variable capacitor and high precision constant voltage circuit. Also the small chip size of this product enables a smaller VCXO.

■ Features

- Crystal frequency : 80~170MHz
- Output : CMOS
- Divide function : No divide
- Power supply voltage : 2.97~3.63V
- Vc Input impedance : 5MΩ
- Standby function : Oscillation stop
- Operation temperature : 85°C (Please contact us about 105°C usage.)
- Small chip size : 0.70mm × 0.75mm
- Frequency stability to Vdd : Within ±2ppm
- Wide pulling range : ±90ppm minimum / Vc=1.65±1.65V
- Duty cycle : Within 50±5%

1. Part number rule

2. Series

Part Number	Output Frequency (MHz)		Divide	Remarks
	Min.	Max.		
IPV005 6 H 0	80.00	170.00	1/1	
IPV005 6 H 0 B	80.00	170.00	1/1	Lower Phase Noise

3. Absolute Maximum Ratings $V_{SS}=0V$, $T_a=+25^{\circ}C \pm 2^{\circ}C$

Parameter	Symbol	Condition	Ratings		
			Min	Max	Unit
Supply Voltage	V_{DD}		$V_{SS}-0.5$	5	V
Input Voltage	V_{IN}	All Input Pin	$V_{SS}-0.5$	$V_{DD}+0.5$	V
Output Voltage	V_{OUT}		$V_{SS}-0.5$	$V_{DD}+0.5$	V
Output Current	I_{OUT}	IPV0056H0		30	mA
		IPV0056H0B		25	mA
Junction Temperature	T_j		-55	150	$^{\circ}C$
Storage Temperature	T_{stg}		-55	125	$^{\circ}C$

4. Recommended Operating Condition $V_{SS}=0V$, $T_a=-40\sim 85^{\circ}C$

Parameter	Symbol	Condition	Min	Typ	Max	Unit	Note
Supply Voltage	V_{DD}		2.97	3.3	3.63	V	V_{DD}
“H” Input Voltage	V_{IH}		$V_{DD} \times 0.7$			V	CE
“L” Input Voltage	V_{IL}				$V_{DD} \times 0.3$	V	CE
Input Voltage	V_{IN}		V_{SS}		V_{DD}	V	CE
Output Load Capacitance	CL	CMOS			15	pF	OUT
Ambient Temperature	T_{opT}		-40		85	$^{\circ}C$	

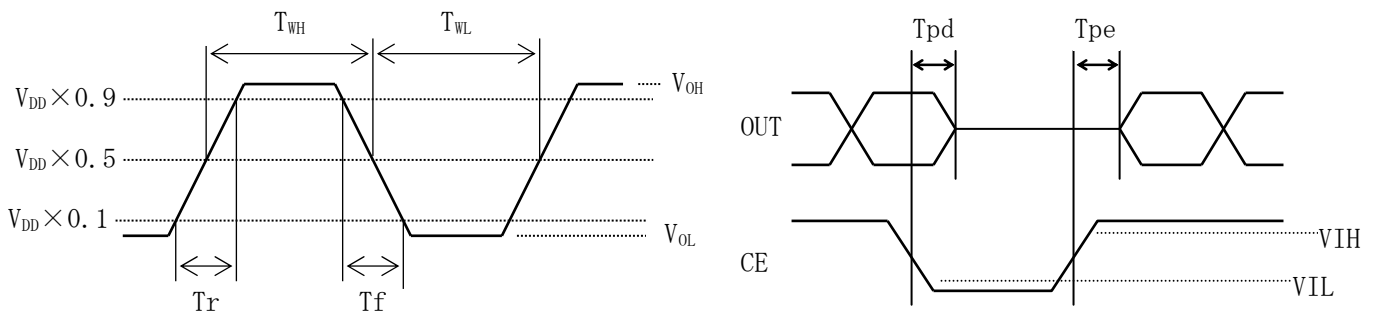
Please contact us about $105^{\circ}C$ usage.

5. Electrical Specification

 Unless otherwise stated, $V_{DD}=2.97\sim 3.63V$, $V_{SS}=0V$, $T_a=-40\sim 85^\circ C$

 (Please contact us about $105^\circ C$ usage.)

Parameter	Symbol	Condition	Specification			Unit
			Min	Typ	Max	
“H” input current	I_{IH}	IPV0056H0 $V_{IN}=V_{DD}$			1	μA
		IPV0056H0B $V_{IN}=V_{DD}$			30	μA
“L” input current	I_{IL}	IPV0056H0 $CE \leq 0.3V$	-10			μA
		IPV0056H0B $CE \leq 0.3V$	-60			μA
“H” output voltage	V_{OH}	$I_{OH}=-5mA$	$V_{DD}-0.4$			V
		$CL=15pF$	$0.9V_{DD}$			V
“L” output voltage	V_{OL}	$I_{OL}=5mA$			0.4	V
		$CL=15pF$			$0.1V_{DD}$	V
Current consumption	I_{DD}	$CL=15pF$, $CE \geq V_{DD}-0.3V$, $F_0=170MHz$		24	34	mA
Current consumption at oscillation disable	I_{DDD}	IPV0056H0 $CL=15pF$, $V_{DD}=3.63V$, $CE \leq 0.3V$		10	30	μA
		IPV0056H0B $CL=15pF$, $V_{DD}=3.63V$, $CE \leq 0.3V$			60	μA
Output off leak at oscillation disable	I_Z	$CE \leq 0.3V$			10	μA
Output Duty Ratio	Duty	$CL=15pF$	45		55	%
Pull Range	F_{cntr}	$V_c=1.65 \pm 1.65V$, 170MHz ^{*1)}				
		IPV0056H0	± 100			ppm
		IPV0056H0B	± 120			ppm
Rise time	T_r	IPV0056H0		1.4	2.0	ns
Fall time	T_f	$CL=15pF$, 10~90% V_{DD}		1.2	1.8	ns
Rise time	T_r	IPV0056H0B			2.0	ns
Fall time	T_f	$CL=15pF$, 10~90% V_{DD}			2.0	ns
Output Enable Time	T_{pe}				2	ms
Output Disable Time	T_{pd}	IPV0056H0			100	ns
		IPV0056H0B			200	ns
Modulation Band Width	F_c	$V_c=1.35\sin\omega t+1.65V$, -3dB	15	20		KHz

 Crystal ^{*1} ; Equivalent Parameter of Crystal is $\gamma=C_0/C_1<300$


$$Duty = \frac{T_{WH}}{T_{WH} + T_{WL}} \times 100\%$$

 V_{IH} : Threshold voltage for Oscillation Start
 V_{IL} : Threshold voltage for Oscillation Stop

 Fig. 5-1 Output Wave Form (Duty, T_r , T_f , T_{pd} , T_{pe})

6. Phase noise

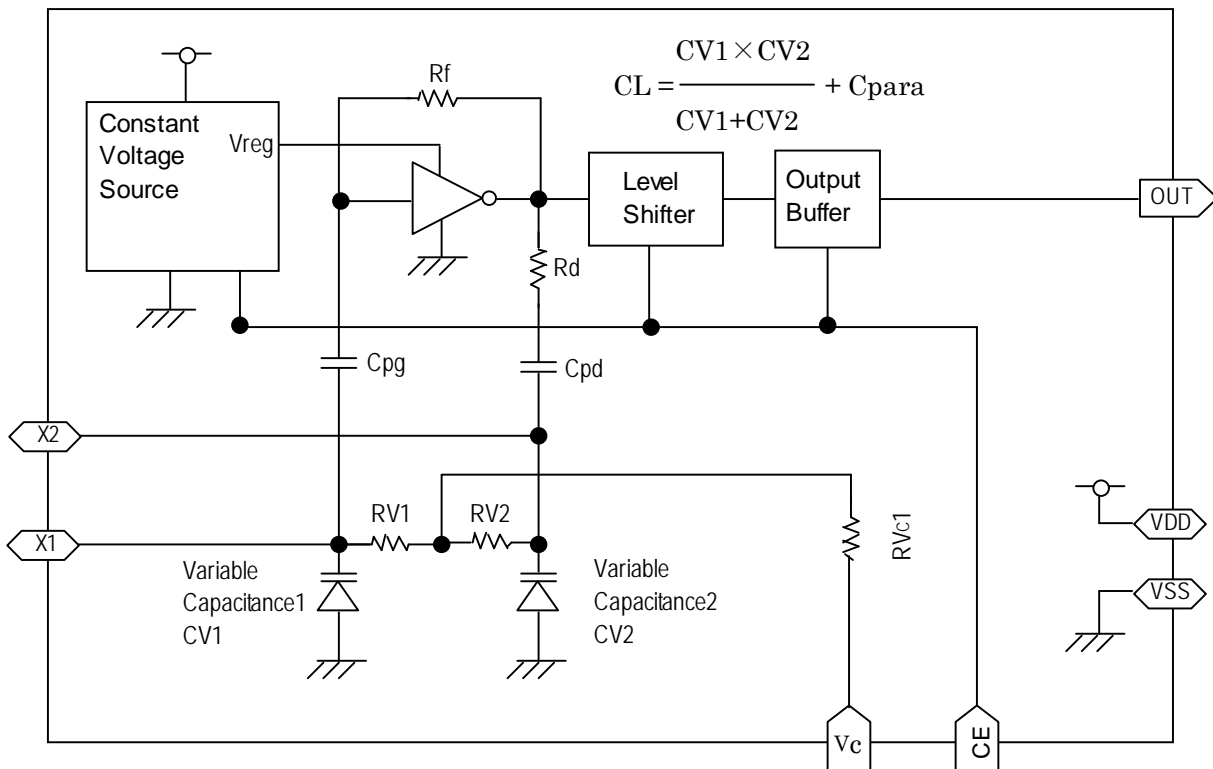
F=155MHz, Vc=1.65V, Room temperature

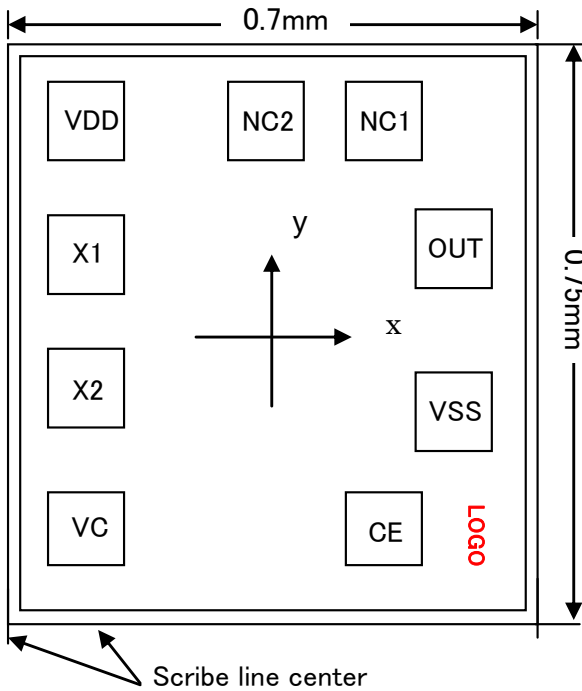
Offset	IPV0056H0	IPV0056H0B
1KHz	-117.6 dBc/Hz	-116.6 dBc/Hz
10KHz	-133.3 dBc/Hz	-137.3 dBc/Hz
100KHz	-145.5 dBc/Hz	-147.2 dBc/Hz
1MHz	-153.8 dBc/Hz	-154.3 dBc/Hz

7. Circuit Parameters of Oscillator (Reference Data for Circuit Design)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Bias Resistor	Rv1			280		KΩ
	Rv2			93		KΩ
Input Resistor	Rvc1			20		KΩ
Feedback Resistor	Rf			100		KΩ
Driving Resistor	Rd			400		Ω
VC Input impedance	Rvc	VC terminal to GND	5			MΩ
Equivalent series (Loading) Capacitance	CLxtal	Vc=0V		6.7		pF
		Vc=1.65V		4.2		
		Vc=3.3V		2.9		
Drive Level	DL	Vc=0V, 135MHz		350		μ W
		Vc=1.65V, 135MHz		240		
		Vc=3.3V, 135MHz		150		
Frequency deviation by IC	$\Delta f/f$	Crystal fixed			25	ppm

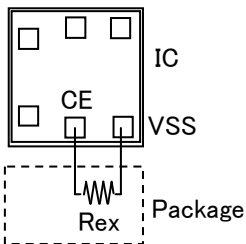
*The above values are the design values and are not guaranteed by test.


Fig 6-1 Block Diagram

8. Pad Layout


- Die Size: 0.75mm × 0.7mm
- Pad Size: 80um □
- Thickness: 150±20um
- IC Backside: Gnd or Open

Pad Name	Function	Location (μm)	
		x	y
VDD	(+)Power Supply	-250.55	275.55
X1	Crystal Feedback	-250.55	86.35
X2	Crystal Drive	-250.55	-94.35
VC	Frequency Control Input	-250.55	-275.55
CE	Oscillation stop	170.55	-275.55
VSS	(-)Ground	250.55	-80.05
OUT	Output	250.55	94.35
NC1	None Connection	170.55	275.55
NC2	None Connection	-1.2	275.55
Chip Center		0	0


IMPORTANT Notice for CE function

- * Rex should be over 10MΩ in case of CE = Open usage.
 - * Oscillation will not be activated when CE = Open after CE = Low if Rex is below 10MΩ.
 - * There is no such issue in case of CE = VDD usage.
- Rex : External resistance value between CE and VSS of package.

7. IC Part # Identification

Part #	LOGO
IPV0056H0	IPV0056H0
IPV0056H0B	IPV0056H0B